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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/777,756	OGIWARA, RYU	
Examiner	Art Unit	
Thinh T. Nguyen	2818	

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Class	Subclass	Date	Examiner
257	295	7/5/2005	TTN
257	296	7/5/2005	TTN
257	22	7/6/2005	TTN
257	E31.029	7/6/2005	TTN
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